



Power MOSFETS

DATASHEET

LM1A500NAP3A

N-Channel
Enhancement Mode MOSFET

 Leadpower-semiconductor Corp., Ltd

 sales@leadpower-semi.com

 (03) 6577339 FAX : (03) 6577229

 www.leadpower-semi.com

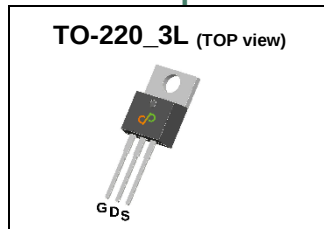


Quality Management Systems

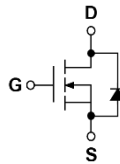
ISO 9001:2015 Certificate

N-Channel Enhancement Mode MOSFET

Pin Description



Symbol



Product Summary

Symbol	N-Channel	Unit
V_{DSS}	100	V
$R_{DS(ON)-Max}$	43	mΩ
ID	27	A

Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS Tested

Applications

- Portable Equipment
- Battery Powered System

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM1A500NAP3A	TO-220-3L	Tube	50	1A500 □□□□□

Note : □□□□□ = Lot Code

Absolute Maximum Ratings ($T_J=25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter		N-Channel	Unit
V_{DSS}	Drain-Source Voltage		100	V
V_{GSS}	Gate-Source Voltage		± 20	
T_J	Maximum Junction Temperature		150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range		-55 to 150	$^\circ\text{C}$
$I_{DM}^{①}$	Pulse Drain Current Tested	$T_C=25^\circ\text{C}$	66	A
I_D	Continuous Drain Current	$T_C=25^\circ\text{C}$	27	A
		$T_C=100^\circ\text{C}$	17	
P_D	Maximum Power Dissipation	$T_C=25^\circ\text{C}$	69	W
		$T_C=100^\circ\text{C}$	28	
$I_{AS}^{②}$	Avalanche Current, Single pulse	$L=0.1\text{mH}$	18	A
$E_{AS}^{③}$	Avalanche Energy, Single pulse	$L=0.1\text{mH}$	16	mJ

Thermal Characteristics

Symbol	Parameter		Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	1.8	$^\circ\text{C/W}$
$R_{\theta JA}^{③}$	Thermal Resistance-Junction to Ambient	Steady State	62.5	$^\circ\text{C/W}$

Note ① : Max. current is limited by junction temperature.

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in^2 FR-4 board with 1oz.

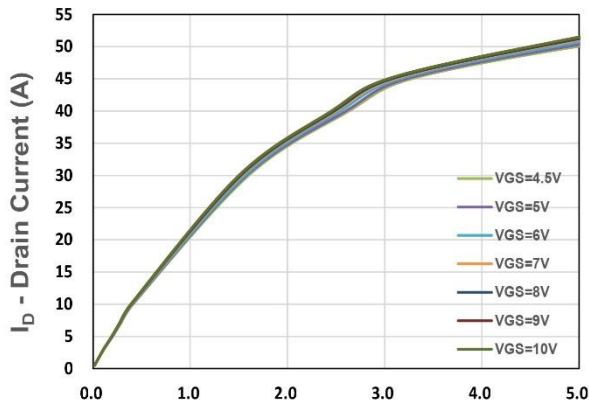
N-Channel Electrical Characteristics ($T_J=25^{\circ}\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250uA	100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =80V, V _{GS} =0V	-	-	1	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250uA	1.3	1.9	2.5	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ④	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =1A	-	36	43	mΩ
		V _{GS} =4.5V, I _{DS} =1A	-	38	49	
gfs	Forward Transconductance	V _{DS} =5V, I _{DS} =0.5A	-	4.9	-	S
Dynamic Characteristics ⑥						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, Freq.=1MHz	-	2.5	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, Freq.=1MHz	-	1711	-	pF
C _{oss}	Output Capacitance		-	67.3	-	
C _{rss}	Reverse Transfer Capacitance		-	28.9	-	
td(ON)	Turn-on Delay Time	V _{GS} =10V, V _{DS} =50V, I _D =1A, R _{GEN} =6Ω	-	4.5	-	nS
tr	Turn-on Rise Time		-	30	-	
td(OFF)	Turn-off Delay Time		-	45	-	
tf	Turn-off Fall Time		-	30	-	
Qg	Total Gate Charge	V _{GS} =4.5V, V _{DS} =50V I _D =1A	-	18.05	-	nC
Qg	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =1A	-	33.2	-	
Qgs	Gate-Source Charge		-	4	-	
Qgd	Gate-Drain Charge		-	6	-	
Source-Drain Characteristics						
VSD④	Diode Forward Voltage	ISD=0.5A, VGS=0V	-	0.7	1.1	V
trr	Reverse Recovery Time	IF=1A, VR=50V	-	24.4	-	nS
Qrr	Reverse Recovery Charge	dIF/dt=100A/μs	-	18.7	-	nC

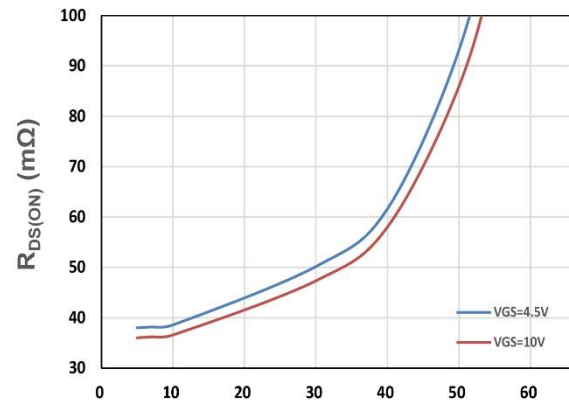
Note ④ : Pulse test (pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$).

Note ⑤ : Guaranteed by design, not subject to production testing.

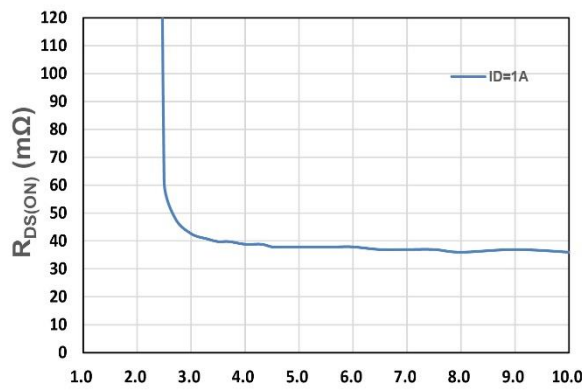
N-Channel Typical Characteristics



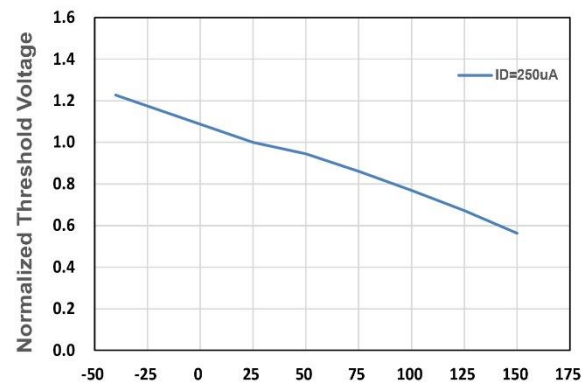
V_{DS} - Drain - Source Voltage (V)
Figure 1. Output Characteristics



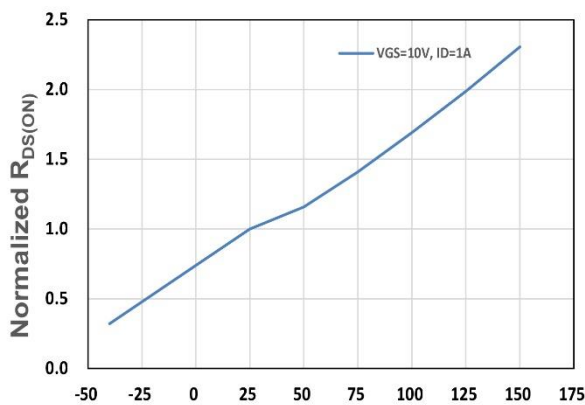
I_D - Drain Current (A)
Figure 2. On-Resistance vs. ID



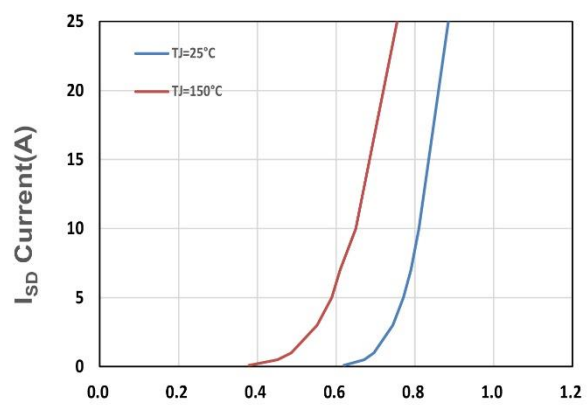
V_{GS} - Gate - Source Voltage (V)
Figure 3. On-Resistance vs. VGS



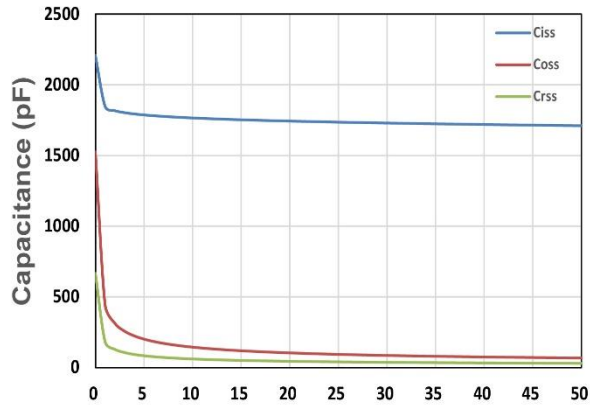
T_j , Junction Temperature(°C)
Figure 4. Gate Threshold Voltage



T_j , Junction Temperature(°C)
Figure 5. Drain-Source On Resistance

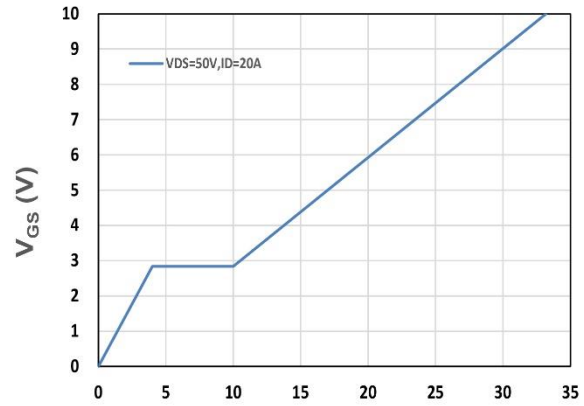


V_{SD} , Source-Drain Voltage(V)
Figure 6. Source-Drain Diode Forward



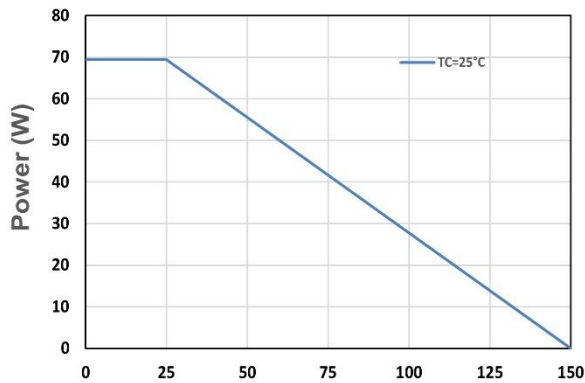
V_{DS} - Drain - Source Voltage (V)

Figure 7. Capacitance



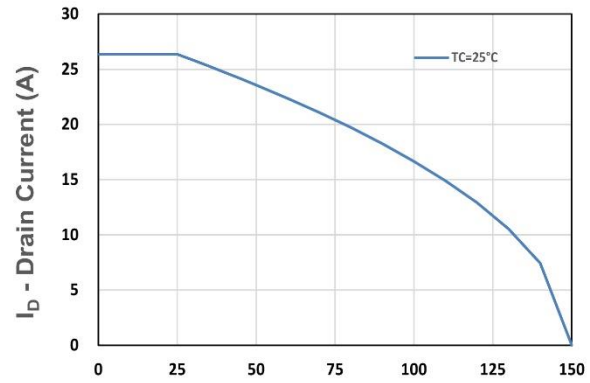
Q_g , Total Gate Charge (nC)

Figure 8. Gate Charge Characteristics



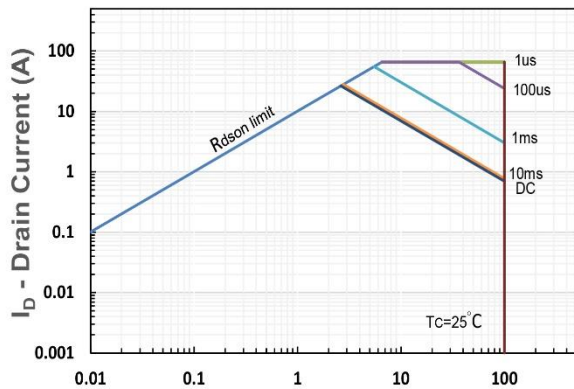
T_C - Junction Temperature (°C)

Figure 9. Power Dissipation



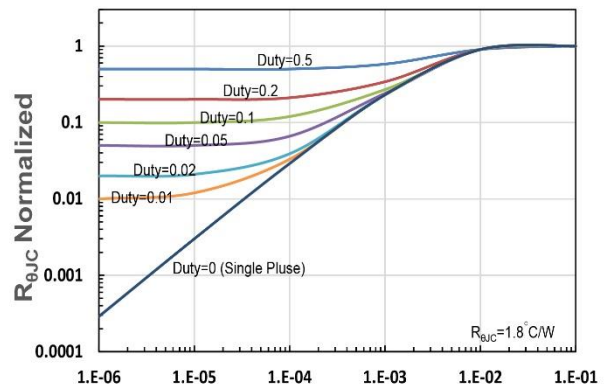
T_C - Junction Temperature (°C)

Figure 10. Drain Current



V_{DS} - Drain-Source Voltage (V)

Figure 11. Safe Operating Area



t_1 , Square Wave Pulse Duration(s)

Figure 12. $R_{\theta JC}$ Transient Thermal Impedance